

## EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S1	10	("5592571" "5715334" "6324298" "6337472" "20020125136").pn.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 12:59
S2	360	(dye fluorescence ink) with (bright dark illumination) with (semiconductor chip electronic)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/16 15:11
S3	9	(dye fluorescence ink) near2 (bright dark illumination) near2 (semiconductor chip electronic)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 14:58
S4	4	(dye fluorescence ink) with (bright dark illumination) with (semiconductor chip electronic) with (defect failure)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 14:44
S5	27	382/145.ccls. and (ink fluorescence ink)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 13:25
S6	28	382/145.ccls. and (ink fluorescence dye)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 14:20
S7	769	382/145.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 14:20
S8	81	(dye fluorescence ink) same (bright dark illumination) same (semiconductor chip electronic) same (defect failure delamination)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 14:57

## EAST Search History

S9	26098	(fluorescence) same (ink dye)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 14:58
S10	16271	(fluorescence) with (ink dye)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 14:58
S11	0	fluorescence near2 (dye ink) near2 (bright dark illumination) near2 (semiconductor chip electronic)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 14:59
S12	30	fluorescence with (dye ink) with (bright dark illumination) with (semiconductor chip electronic)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 15:03
S13	472	(bright dark illumination fluorescence) with (dye ink) with (semiconductor chip electronic)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 15:00
S14	291	fluorescence with (dye ink) with (semiconductor chip electronic)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 15:01
S15	4	fluorescence with (dye ink) with (semiconductor chip electronic) with (defect failure delamination)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 15:02
S16	291	fluorescence with (dye ink) with (semiconductor chip electronic)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 15:05
S17	5	fluorescence with (dye ink) with (semiconductor chip electronic) with (inspection defect failure delamination)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 15:05

## EAST Search History

S18	10	("5592571" "5715334" "6324298" "6337472" "20020125136").pn.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 15:09
S19	4	fluorescence with (dye ink) with (semiconductor chip electronic) with (defect failure delamination)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 15:10
S20	16	fluorescence near2 (dye ink) and (semiconductor chip electronic) near2 (defect failure delamination inspection)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 15:14
S21	4	"3557015".pn.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 15:14
S22	5	("3557015").URPN.	USPAT	OR	ON	2006/10/10 15:17
S23	311	382/144.ccls.	USPAT	OR	ON	2006/10/10 15:17
S24	2	382/144.ccls. and (dye ink)	USPAT	OR	ON	2006/10/10 15:17
S25	5	382/144.ccls. and (dye ink)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 15:38
S26	6499	(crack near2 detect\$4)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 15:29
S27	50	(crack near2 detect\$4) and (semiconductor chip) near2 (inspect\$4)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 19:50

## EAST Search History

S28	3	(crack near2 detect\$4) and (semiconductor chip) near2 (inspect\$4) and (ink dye)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 15:53
S29	198	382/141-153.ccls. and (dye ink)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 15:46
S30	20	382/141-153.ccls. and fluorescence with (dye ink)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 15:49
S31	7	382/141-152.ccls. and fluorescence with (dye ink)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 15:49
S32	1	(crack near2 detect\$4) and (semiconductor chip) with (inspect\$4) with (ink dye)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 15:56
S33	850	438/15.ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 15:57
S34	67	438/15.ccls. and (ink dye)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 15:57

## EAST Search History

S35	51	438/15.ccls. and (ink dye) and (crack failure defect\$4)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 15:59
S36	0	438/15.ccls. and (ink dye) with fluorescence	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 16:00
S37	1	438/15.ccls. and (ink dye) with fluorescen\$3	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 16:05
S38	1	438/15.ccls. and (ink dye) same fluorescen\$3 _	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 16:05
S39	2	438/15.ccls. and (ink dye) and fluorescen\$3	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 16:06
S40	2	"5570431".pn.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 16:06
S41	11	("3791198"   "4483615"   "4506980"   "4650326"   "4931949"   "5004339"   "5125741").PN. OR ("5570431").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2006/10/10 16:07
S42	67	(crack near2 detection) and (ink dye) near2 fluorescen\$2	US-PGPUB; USPAT; USOCR	OR	ON	2006/10/10 16:08
S43	3990	382/141-152.ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 19:50

## EAST Search History

S44	133	382/141-152.ccls. and (ultrasound acoustic)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 19:53
S45	3	"4218922".pn.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/10 19:53
S46	65	fluorescen\$2 with (crack) with (detection)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/11 15:54
S47	12	fluorescen\$2 near (crack) near (detection)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/11 15:54
S48	2	airplane with bolt with dye	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/13 16:36
S49	86	airplane near2 bolt	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/13 19:40
S50	44	airplane near bolt	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/13 16:36
S51	0	airplane near2 bolt and dye	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/13 16:36

## EAST Search History

S52	0	airplane near2 bolt and ink	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/13 16:36
S53	2	encapsulat\$4 with dye with (crack failure defect) with wick\$4	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/13 19:43
S54	0	250/201.03.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/13 19:43
S55	400	250/201.3.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/13 19:44
S56	63	250/201.3.ccls. and (defect failure)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/13 19:59
S57	0	250/201.3.ccls. and (ink dye) with inspection	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/13 20:00
S58	3211	(ink dye) with inspection	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/13 20:00
S59	589	(ink dye) near2 inspection	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/13 20:00
S60	0	(ink dye) near2 inspection near encapsulat\$4	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/13 20:01

## EAST Search History

S61	0	(ink dye) near2 inspection with encapsulat\$4	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/13 20:02
S62	2	"20040125992".pn.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/13 20:02
S64	91	airplane and bolt and dye	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/15 12:19
S65	20	airplane and bolt and dye and inspection	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/15 15:51
S66	118060	airplane dye and inspection	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/15 12:29
S67	257	airplane and dye and inspection	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/15 12:29
S68	6	airplane and dye near2 inspection	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/15 12:34
S69	20	airplane and dye with inspection	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/15 13:42
S70	114	aircraft and dye with inspection	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/15 13:42



## EAST Search History

S71	99	aircraft and dye with inspection not S69	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/15 14:40
S72	3991	382/141-152.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/15 14:40
S73	2	382/141-152.ccls. and (dye near2 inspect\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/15 14:41
S74	21802	dye and inspection	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/15 15:51
S75	303	dye near2 inspection	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/15 15:51
S76	1	(semiconductor electronic) with (dye near2 inspection)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/15 16:09
S77	0	(wick\$4) with (dye near2 inspection)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/15 16:09
S78	35	(wick\$4) and (dye near2 inspection)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/15 16:09
S79	38	382/141-152.ccls. and (dark near illuminat\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/16 15:13

## EAST Search History

S81	38	382/141-152.ccls. and (dark near illuminat\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/16 23:15
S82	2	"6342400".pn.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/10/16 23:15
S83	4	("4230754"   "5651493"   "6117352"   "6117695").PN. OR ("6342400").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2006/10/17 01:00
S84	4	(Xanthane Naphthalimide Perylene Courmarin Fluorescein) and (dye near inspection)	US-PGPUB; USPAT; USOCR	OR	ON	2006/10/17 02:21
S85	851	438/15.ccls.	US-PGPUB; USPAT; USOCR	OR	ON	2006/10/17 02:21
S86	0	438/15.ccls. and (grind\$4 and polish\$4) with (cross near section)	US-PGPUB; USPAT; USOCR	OR	ON	2006/10/17 02:22
S87	38	438/15.ccls. and (grind\$4 and polish\$4)	US-PGPUB; USPAT; USOCR	OR	ON	2006/10/17 03:50
S88	445	438/15.ccls. and (cross near section\$4)	US-PGPUB; USPAT; USOCR	OR	ON	2006/10/17 03:49
S89	4	438/15.ccls. and (cross near sectioning)	US-PGPUB; USPAT; USOCR	OR	ON	2006/10/17 03:11
S90	36	dye near inspection and (cross near section\$4)	US-PGPUB; USPAT; USOCR	OR	ON	2006/10/17 05:04
S91	0	dye near inspection and (grind\$4 and polish\$4)	US-PGPUB; USPAT; USOCR	OR	ON	2006/10/17 03:50